

Notice of References Cited

Application/Control No.

10/086,025

Applicant(s)/Patent Under
Reexamination
ANDERSON ET AL.

Examiner

Arlen Soderquist

Art Unit

1743

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,777,214	07-1998	Thompson et al.	73/61.59
	B	US-5,983,734	11-1999	Mathur et al.	73/864.24
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	2,294,761	05-1996	GB	Dureault et al.	
	O	99/39198	08-1999	WO	Kingston	
	P	131310	05-2000	JP	Tamaoki et al.	
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Marchante-Gayon, J. M. et al, Special Publication - Royal Society of Chemistry 1997, 202, 85-94.
	V	Wiederin, D. R. et al, Analytical Chemistyr 1991, 63, 1626-1631.
	W	Seubert, A. Fresenius J. Anal. Chem. 1999, 364, 404-409.
	X	Dahmen, J. et al, Fresenius J. Anal. Chem. 1997, 359, 410-413.

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Beauchemin, D. et al, Analytical Chemistry 1997, 69, 3183-3187.
	V	Bartels, H. et al, GIT Fachz. Lab. 1977, 21, 1276-1278 and 1280-1282
	W	Slobodnik J. et al, Journal of Chromatography A 1996, 730, 353-371.
	X	Huang, C.-C. et al, Analytical Chemistry 1997, 69, 3930-3939.

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Multala, R. et al, Kemia-Kemi 1977, 4, 627-631.
	V	
	W	
	X	

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